

## P-channel 20 V, 0.0195 $\Omega$ typ., 9 A STripFET™ H7 Power MOSFET in a PowerFLAT™ 3.3x3.3 package

Datasheet - production data

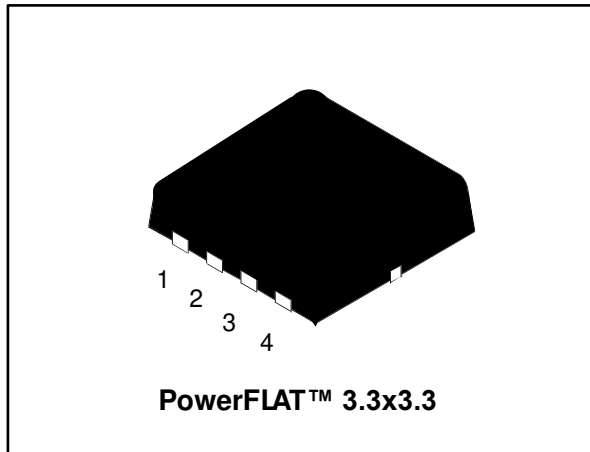
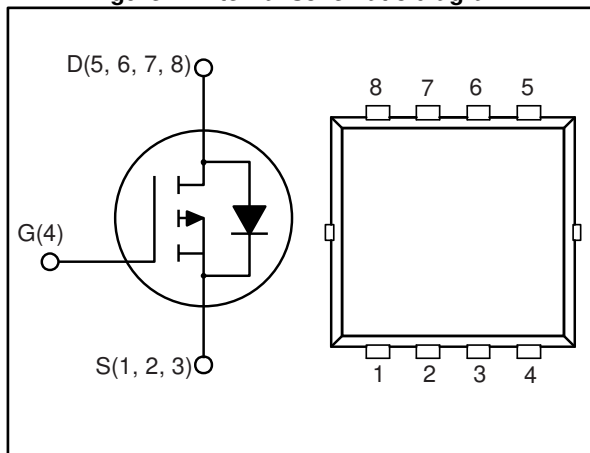


Figure 1: Internal schematic diagram



- Very low on-resistance
- Very low capacitance and gate charge
- High avalanche ruggedness

### Applications


- Switching applications

### Description

This P-channel Power MOSFET utilizes the STripFET H7 technology with a trench gate structure combined with extremely low on-resistance. The device also offers ultra-low capacitances for higher switching frequency operations.

Table 1: Device summary

Order code	Marking	Package	Packaging
STL9P2UH7	9P2H7	PowerFLAT™ 3.3x3.3	Tape and reel

 For the P-channel Power MOSFET the actual polarity of the voltages and the current must be reversed.

### Features

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STL9P2UH7	20 V	0.0225 $\Omega$ @ 4.5 V	9 A

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# 1 Electrical ratings

**Table 2: Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	20	V
$V_{GS}$	Gate-source voltage	$\pm 8$	V
$I_D^{(1)}$	Drain current (continuous) at $T_{pcb}= 25\text{ }^\circ\text{C}$	9	A
$I_D^{(1)}$	Drain current (continuous) at $T_{pcb}= 100\text{ }^\circ\text{C}$	5.9	A
$I_{DM}^{(2)}$	Drain current (pulsed)	36	A
$P_{TOT}^{(1)}$	Total dissipation at $T_{pcb}= 25\text{ }^\circ\text{C}$	2.9	W
$T_{stg}$	Storage temperature	- 55 to 150	$^\circ\text{C}$
$T_j$	Max. operating junction temperature	150	$^\circ\text{C}$

**Notes:**

<sup>(1)</sup>The value is rated according to  $R_{thj-pcb}$

<sup>(2)</sup>Pulse width limited by safe operating area

**Table 3: Thermal resistance**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case	2.5	$^\circ\text{C}/\text{W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb	42	$^\circ\text{C}/\text{W}$

**Notes:**

<sup>(1)</sup>When mounted on FR-4 board of 1inch<sup>2</sup>, 2oz Cu,  $t < 10\text{ sec}$ .



For the P-channel Power MOSFET the actual polarity of the voltages and the current must be reversed.

## 2 Electrical characteristics

(T<sub>C</sub> = 25 °C unless otherwise specified)

**Table 4: On /off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	V <sub>GS</sub> = 0, I <sub>D</sub> = 250 μA	20			V
I <sub>DSS</sub>	Zero gate voltage drain current	V <sub>GS</sub> = 0, V <sub>DS</sub> = 20 V			1	μA
I <sub>GSS</sub>	Gate-body leakage current	V <sub>DS</sub> = 0, V <sub>GS</sub> = ± 5 V			± 5	μA
V <sub>GS(th)</sub>	Gate threshold voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	0.4		1	V
R <sub>DS(on)</sub>	Static drain-source on-resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 4.5 A		0.0195	0.0225	Ω
		V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 4.5 A		0.02	0.025	Ω
		V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 4.5 A		0.036	0.043	Ω
		V <sub>GS</sub> = 1.5 V, I <sub>D</sub> = 4.5 A		0.05	0.085	Ω

**Table 5: Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C <sub>iss</sub>	Input capacitance	V <sub>GS</sub> = 0, V <sub>DS</sub> = 16 V, f = 1 MHz	-	2390	-	pF
C <sub>oss</sub>	Output capacitance		-	220	-	pF
C <sub>rss</sub>	Reverse transfer capacitance		-	188	-	pF
Q <sub>g</sub>	Total gate charge	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 9 A, V <sub>GS</sub> = 4.5 V	-	22	-	nC
Q <sub>gs</sub>	Gate-source charge		-	4.2	-	nC
Q <sub>gd</sub>	Gate-drain charge		-	3.6	-	nC

**Table 6: Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	V <sub>DD</sub> = 16 V, I <sub>D</sub> = 9 A, R <sub>G</sub> = 1 Ω, V <sub>GS</sub> = 4.5 V	-	12.5	-	ns
t <sub>r</sub>	Rise time		-	30.5	-	ns
t <sub>d(off)</sub>	Turn-off delay time		-	128	-	ns
t <sub>f</sub>	Fall time		-	84.5	-	ns

Table 7: Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{SD}^{(1)}$	Forward on voltage	$V_{GS} = 0, I_{SD} = 1 \text{ A}$	-	-	1	V
$t_{rr}$	Reverse recovery time	$V_{DD} = 16 \text{ V}$ $di/dt = 100 \text{ A}/\mu\text{s}, I_{SD} = 1 \text{ A}$	-	15.8		ns
$Q_{rr}$	Reverse recovery charge		-	5.9		nC
$I_{RRM}$	Reverse recovery current		-	0.7		A

**Notes:**

<sup>(1)</sup>Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%



For the P-channel Power MOSFET the actual polarity of the voltages and the current must be reversed.

## 2.1 Electrical characteristics (curves)

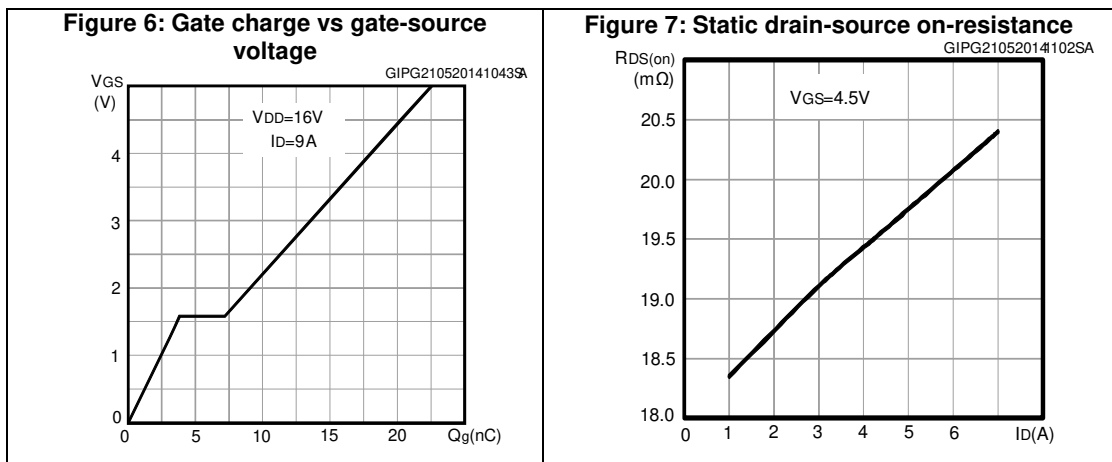
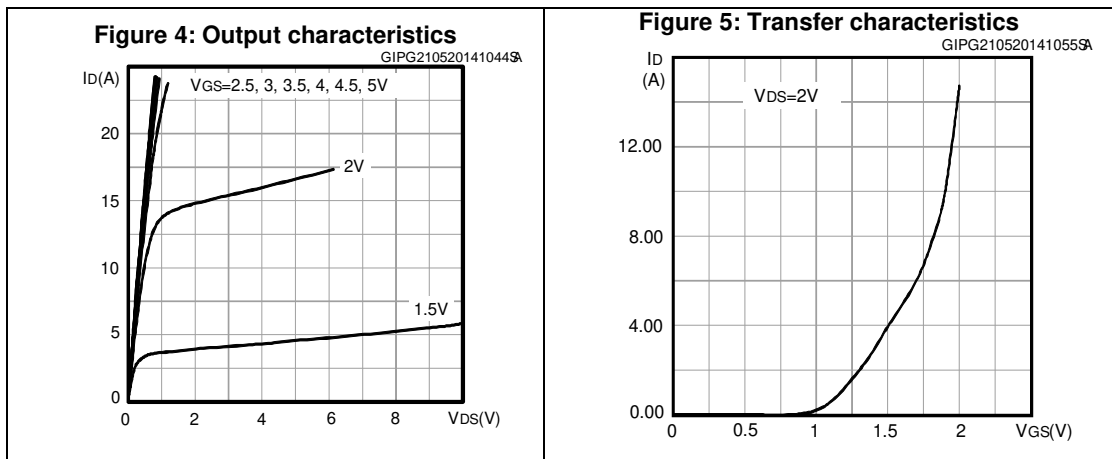
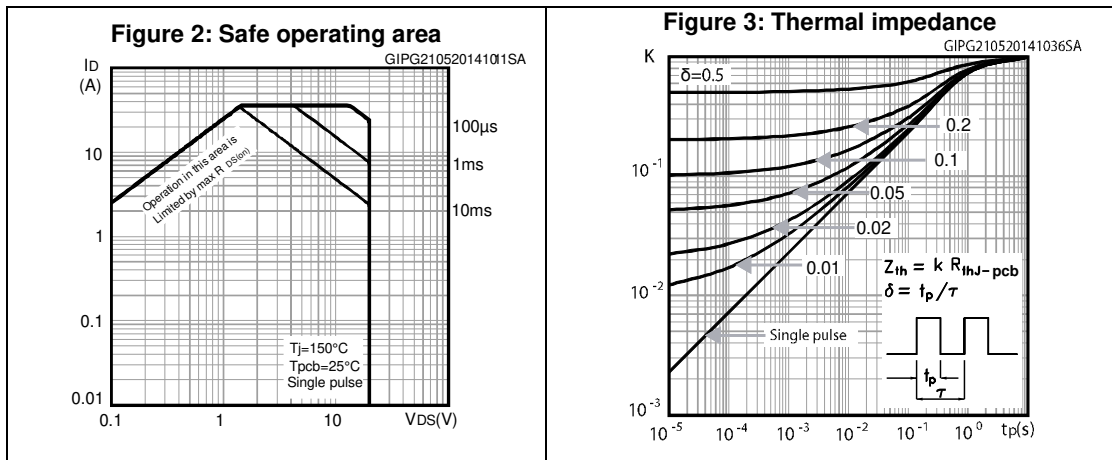


Figure 8: Capacitance variations

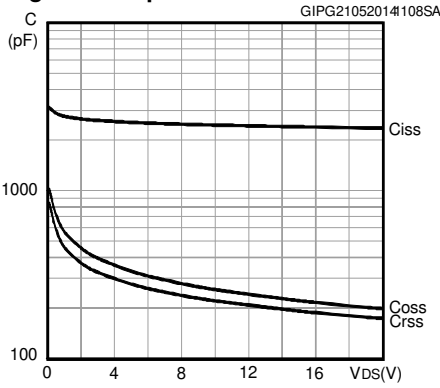


Figure 9: Normalized gate threshold voltage vs temperature

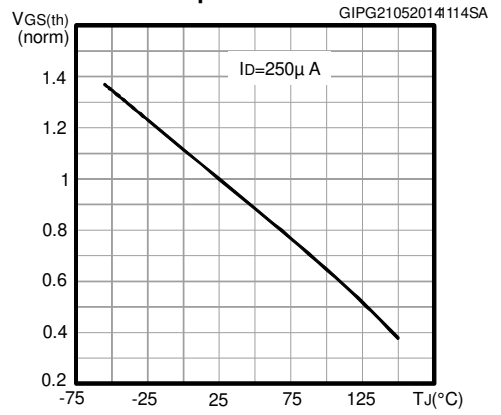


Figure 10: Normalized on-resistance vs temperature

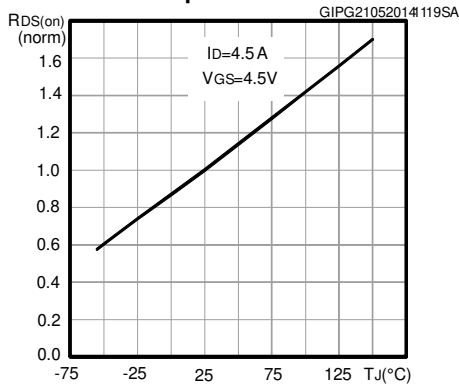


Figure 11: Normalized V(BR)DSS vs temperature

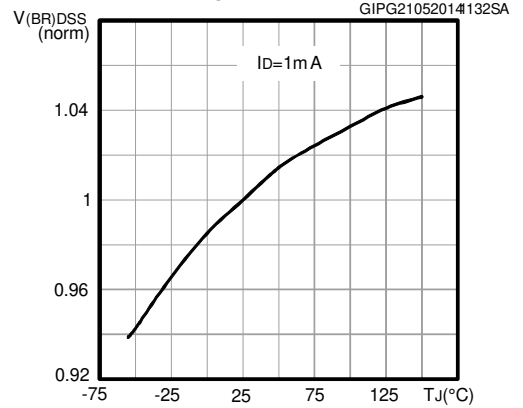
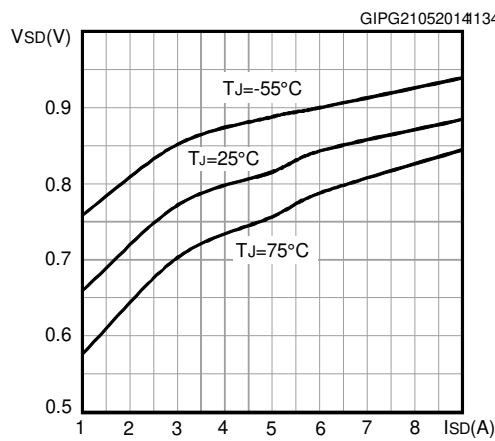
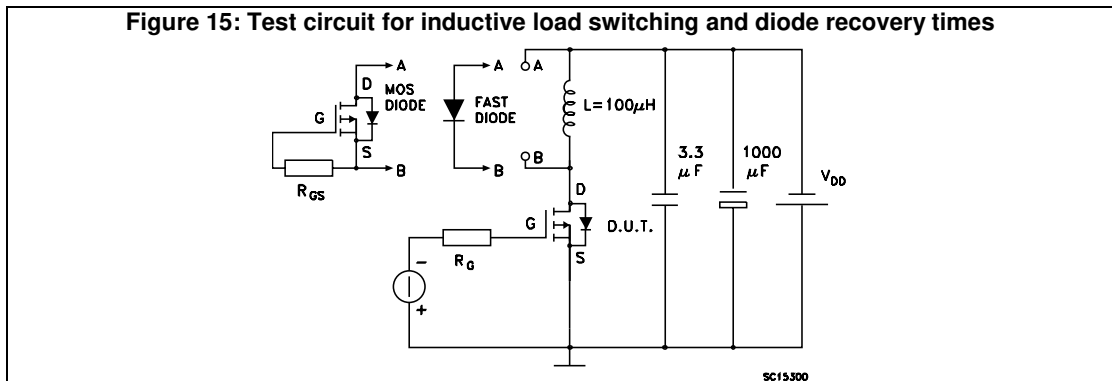
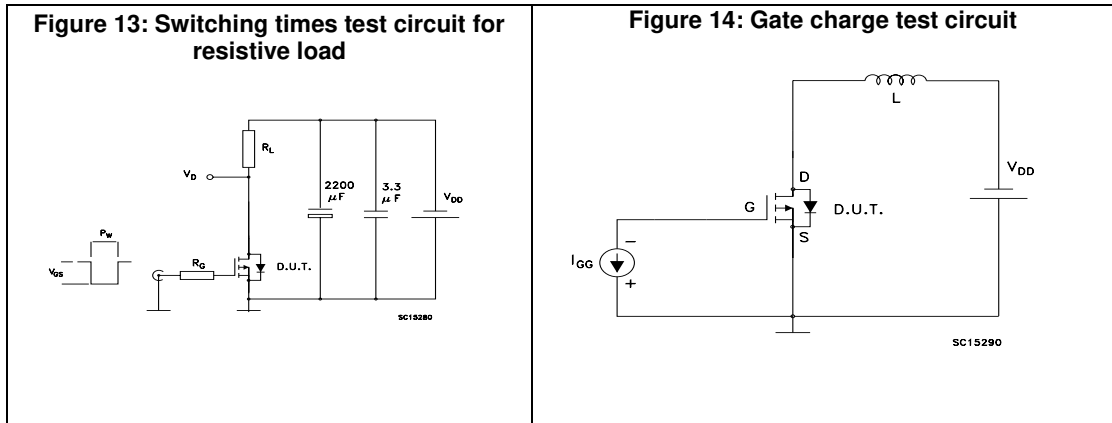


Figure 12: Source-drain diode forward characteristics



### 3 Test circuits



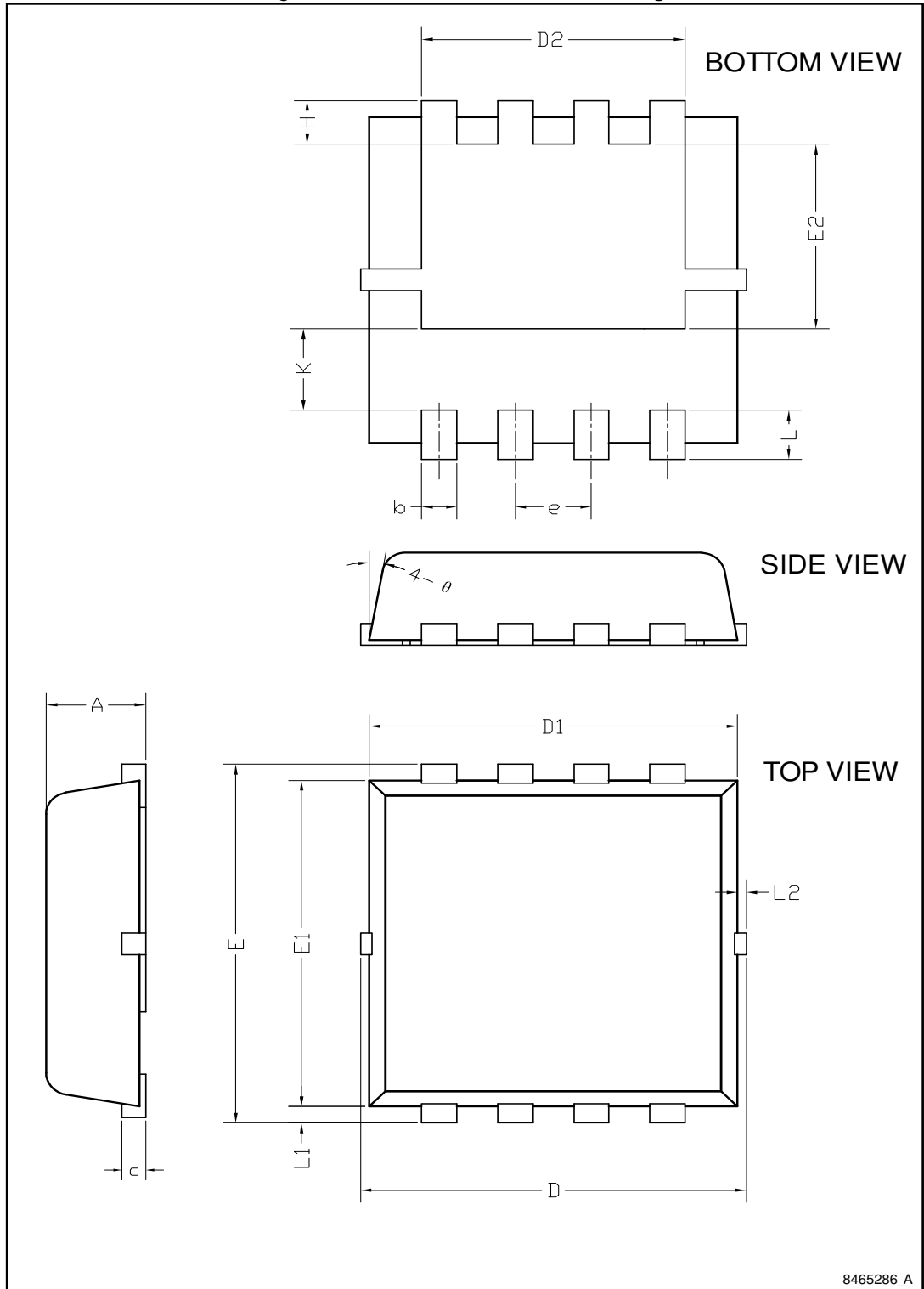


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

### 4.1 PowerFLAT™ 3.3 x 3.3 package mechanical data

Figure 16: PowerFLAT™ 3.3 x 3.3 drawing

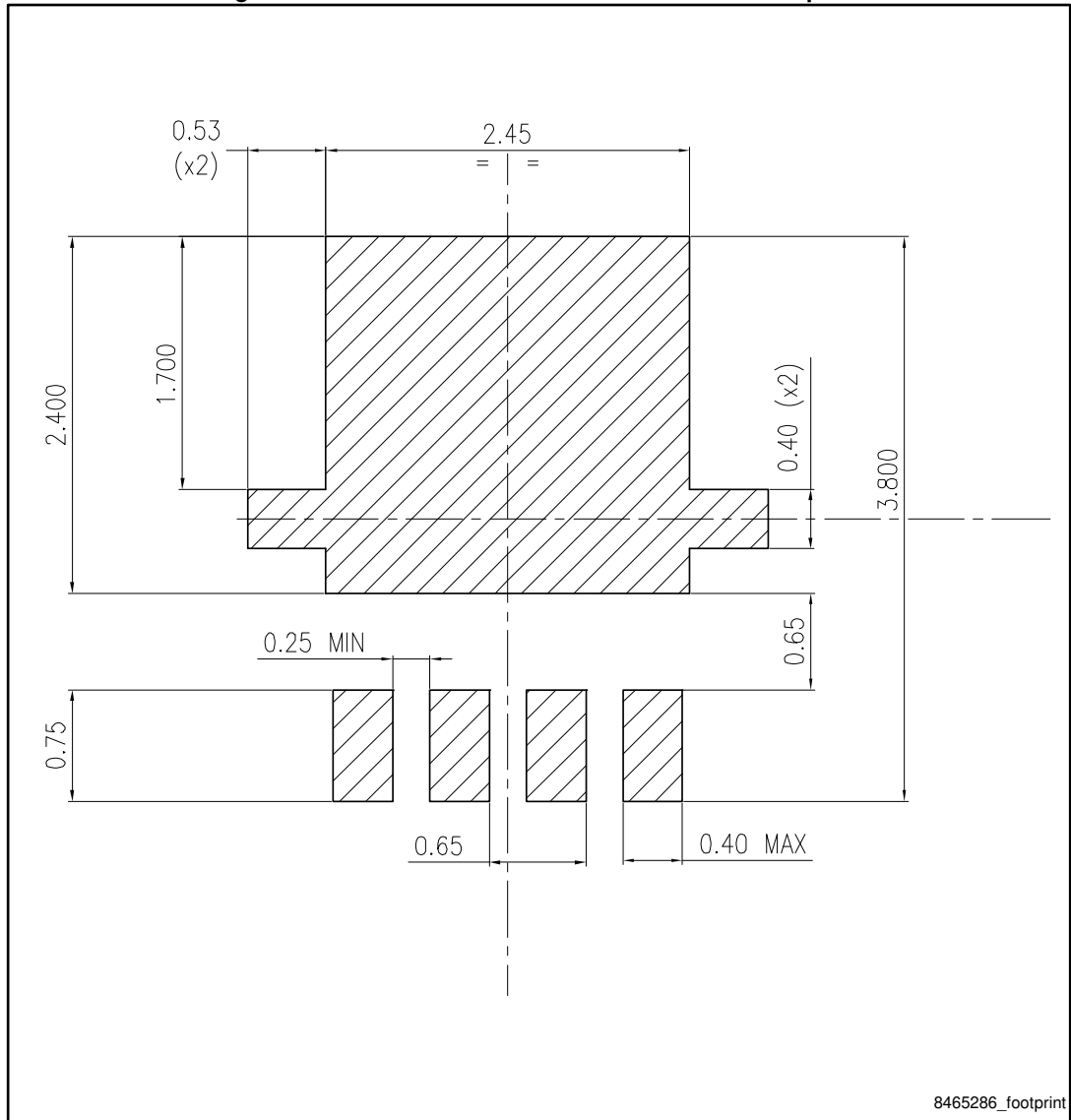


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Table 8: PowerFLAT™ 3.3 x 3.3 mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.70	0.80	0.90
b	0.25	0.30	0.39
c	0.14	0.15	0.20
D	3.10	3.30	3.50
D1	3.05	3.15	3.25
D2	2.15	2.25	2.35
e	0.55	0.65	0.75
E	3.10	3.30	3.50
E1	2.90	3.00	3.10
E2	1.60	1.70	1.80
H	0.25	0.40	0.55
K	0.65	0.75	0.85
L	0.30	0.45	0.60
L1	0.05	0.15	0.25
L2			0.15
J	8°	10°	12°

Figure 17: PowerFLAT™ 3.3 x 3.3 recommended footprint



## 5 Revision history

**Table 9: Document revision history**

Date	Revision	Changes
26-Aug-2013	1	First release.
04-Jun-2014	2	Document status promoted from preliminary data to production data Modified: title Modified: $R_{DS(on)}$ max value in cover page Modified: $R_{DS(on)}$ (typical and maximum) values in <a href="#">Table 4: "On /off states"</a> Modified: the entire typical values in <a href="#">Table 5: "Dynamic"</a> , <a href="#">Table 6: "Switching times"</a> and <a href="#">Table 7: "Source drain diode"</a> Added: <a href="#">Section 8.1: "Electrical characteristics (curves)"</a> Minor text changes
21-Oct-2014	3	Updated the title, the features and the description in cover page. Updated <a href="#">Figure 1: "Internal schematic diagram"</a> . Minor text changes.

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